

# Search Notes



Application/Control No.

10/809,399

Examiner

Dalena Tran

Applicant(s)/Patent under Reexamination

YAMAKAWA ET AL.

Art Unit

3661

## SEARCHED

Class	Subclass	Date	Examiner
701	25 37 39		
	45, 46		
702	182		
	183		
	184		
	185		
700	21, 79	12/1/06	DT
	80		
714	25		
	37		
	39		
	45		
	46		

## INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

## SEARCH NOTES (INCLUDING SEARCH STRATEGY)

	DATE	EXMR
EAST	11/29/06	DT